



EMC TEST REPORT

Report No.: SET2018-15561

Product Name: Bluetooth UHF Reader

FCC ID: 2ABREIVF-BU01

Model No.: IVF-BU01

Applicant: Xiamen Innov Information Technology Co.,LTD

Address: INNOV Industrial Park, Tong Long two Road 943, Xiang An district,

Xiamen city, Fujian Province, China

Received Date: 2018-11-12

Tested Date: 2018-11-12—2018-12-06

Issued by: CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd.

Building 28/29, East of Shigu Xili Industrial Zone, Nanshan District Lab Location:

Shenzhen, Guangdong 518055, China

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Manufacturer....: Xiamen Innov Information Technology Co.,LTD

Manufacturer Address: INNOV Industrial Park, Tong Long two Road 943, Xiang An

district, Xiamen city, Fujian Province, China

Test Standards.....: 47 CFR Part 15 Subpart B: Radio Frequency Devices

Test Result: PASS

Tested by: Yun Lie Form!

Yun Lei Fang Test Engineer 2018.12.12

Reviewed by....:: Chris

Chris You Senior Engineer 2018.12.12

Approved by: 2/m @;

Zhu Qi, Manager

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1. GENERAL INFORMATION

1.1 EUT Description

EUT Name :: Bluetooth UHF Reader FCC ID :: 2ABREIVF-BU01
Trade Name :: XMINOV
Brand Name :: XMINOV
Hardware Version :: IVF-BU01-V1.4
Software Version :: IVF-BU01-V1.1

Note1: The EUT is a Bluetooth UHF Reader;

Note 2:For a more detailed description, please refer to Specification or User's Manual supplied by the applicant and/or manufacturer.

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1.2 Test Standards and Results

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title	
1	47 CFR Part 15	Radio Frequency Devices	
	Subpart B 2017		

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Result
1	15.107	Conducted Emission	PASS
2	15.109	Radiated Emission	PASS

NOTE:

(1) The EUT has been tested according to 47 CFR Part 15 Subpart B,Class B. The test procedure is according to ANSI C63.4:2014.

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1.3 Facilities and Accreditations

1.3.1 Facilities

CNAS-Lab Code: L1659

CCIC-SET is a third party testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L1659.

FCC-Registration No.: CN5031

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Designation Number: CN5031, valid time is until December 31, 2018.

ISED Registration: 11185A-1

CCIC Southern Electronic Product Testing (Shenzhen) Co., Ltd. EMC Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 11185A-1 on Aug. 04, 2016, valid time is until Aug. 03, 2019.

NVLAP Lab Code: 201008-0

CCIC-SET is a third party testing organization accredited by NVLAP according to ISO/IEC 17025. The accreditation certificate number is 201008-0.

1.3.2 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15°C - 35°C
Relative Humidity (%):	25% -75%
Atmospheric Pressure (kPa):	86kPa-106kPa

1.3.3 Measurement Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	Uc = 3.6 dB (k=2)
Uncertainty of Radiated Emission:	Uc = 4.5 dB (k=2)

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2. TEST CONDITIONS SETTING

2.1 Test Peripherals

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Support Equipment:

Description	Brand name	Model	Serial No.	FCCID
Notebook	ThinkPad	E430C	A131101550	N/A
Mouse	Logitech	M100r	25011051	DOC

Support Cable:

Description	Shield Type	Ferrite Core	Length
PC Power adapter Cable	Un- shielding	No	1.2m
Mouse Cable	Un- shielding	No	1m

2.2 Test Mode

The EUT configuration of the emission tests is EUT + PC+ Mouse.

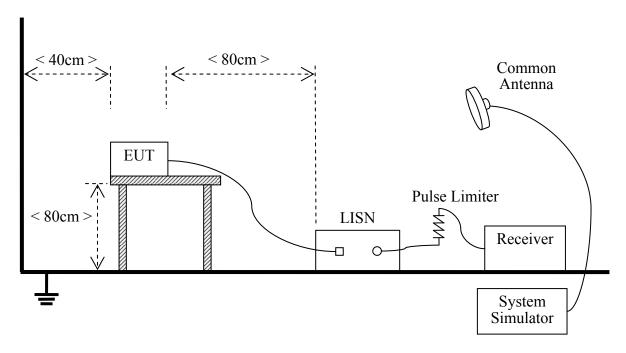
2.3 Test Setup and Equipments List

2.3.1 Conducted Emission

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A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides $50\Omega/50\mu H$ of coupling impedance for the measuring instrument. The Common Antenna is used for the call between the EUT and the System Simulator (SS). A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

B. Equipments List:

Dogarintian	Manufacturer	Model	Serial No.	Calibration	Calibration
Description	Manufacturei	Model	Seriai No.	Date	Due. Date
Test Receiver	KEYSIGHT	N9038A	A141202036	2017.12.13	2018.12.12
LISN	ROHDE&SCHWARZ	ENV216	A140701847	2018.01.08	2019.01.07
Cable	MATCHING PAD	W7	/	2018.04.02	2019.04.01

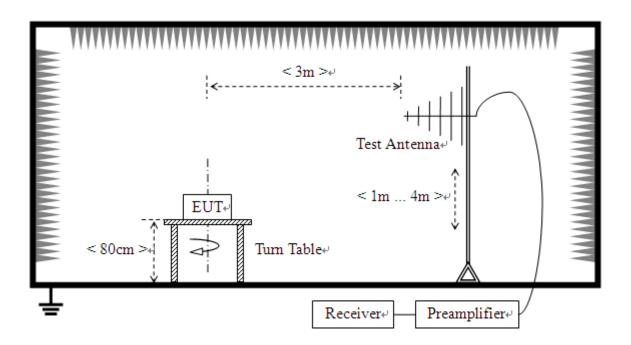
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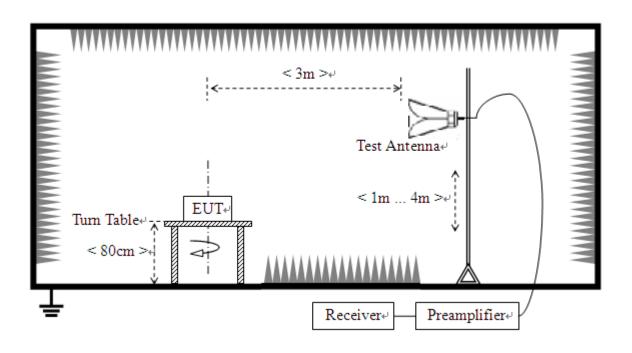
2.3.2 Radiated Emission

A. Test Setup:

1) For radiated emissions from 30MHz to1GHz



2) For radiated emissions above 1GHz



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B. Test Procedure

The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

1) In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

C. Equipments List:

Description	Manufacturer	Model	Serial No.	Calibration	Calibration	
2 Countries	112001010000	1110 0,01	5011011(0.	Date	Due. Date	
Test Receiver	ROHDE&SCHWARZ	ESIB7	A0501375	2018.08.05	2019.08.05	
Semi-Anechoic	Albatross	9m*6m*6m	A0412372	2018 05 00	2019 05 09	
Chamber	Albanoss	JIII OIII OIII	A0412372	2018.03.09	2019.03.09	
Test Antenna -	ETC	MCTD 2786	A150402239	2018 06 10	2019 06 10	
Bi-Log	LIC	WIC1D 2780	A130402237	2010.00.10	2017.00.10	
Test Antenna –	ROHDE&SCHWARZ	HF906	A0304225	2018 05 26	2019 05 25	
Horn	ROHDL&SCHWARZ	111700	A0304223	2010.03.20	2019.03.23	
Anechoic		SAC-5MAC				
Chamber	Albatross	12.8x6.8x6.4	A0304210	2018.05.09	2019.05.09	
Chamber		m				
Amplifier		MITEQ				
1G~18GHz	ROHDE&SCHWARZ	AFS42-0010 A0509366 203	2018.06.04	2019.06.04		
TG~16G11Z		1800				
Amplifier	Compliance Direction	PAP-0203H	A0509377	2018 06 04	2019 06 04	
20M~3GHz	System	1A1-020311	A0309311	2010.00.04	2019.00.04	
Cable	SUNHNER	SUCOFLEX	/	2018 06 04	2019 06 04	
Caule	SUMINER	100	/	Date Due. Date 01375 2018.08.05 2019.08.05 12372 2018.05.09 2019.05.09 402239 2018.06.10 2019.06.10 04225 2018.05.26 2019.05.25 04210 2018.05.09 2019.05.09 09366 2018.06.04 2019.06.04 09377 2018.06.04 2019.06.04 0/ 2018.06.04 2019.06.04	2019.00.04	
Cable	SUNHNER	SUCOFLEX	MY1758/4	2010.06.04	2010 06 04	
Caule	SUMINER	104	10111/30/4	2010.00.04	2019.00.04	

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3. 47 CFR PART 15B REQUIREMENTS

3.1 Conducted Emission

3.1.1 Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a $50\mu H/50\Omega$ line impedance stabilization network (LISN).

Eraguanay ranga (MIIz)	Conducted Limit (dBμV)			
Frequency range (MHz)	Quasi-peak	Average		
0.15 - 0.50	66 to 56	56 to 46		
0.50 - 5	56	46		
5 - 30	60	50		

Note:

- a) The limit subjects to the Class B digital device.
- b) The lower limit shall apply at the band edges.
- c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 0.50MHz.

3.1.2 Test Description

See section 2.3.1 of this report.

3.1.3 Test Result

The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

Note:

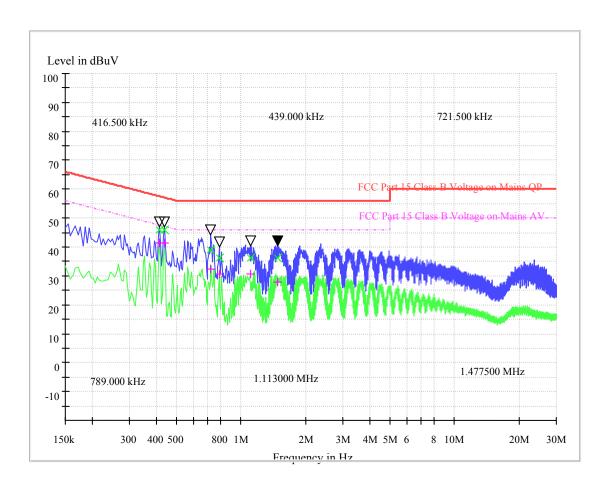
Devices subject to Part 15 must be tested for all available U.S. voltages and frequencies (such as a Nominal 120V AC,50/60Hz) for which the device is capable of operation. A device rated for 50/60 Hz operation need not be tested at both frequencies provided the radiated and line conducted emissions are the same at both frequencies.

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Test voltage and frequency (120V AC,60Hz)

A. Mains terminal disturbance voltage, L phase



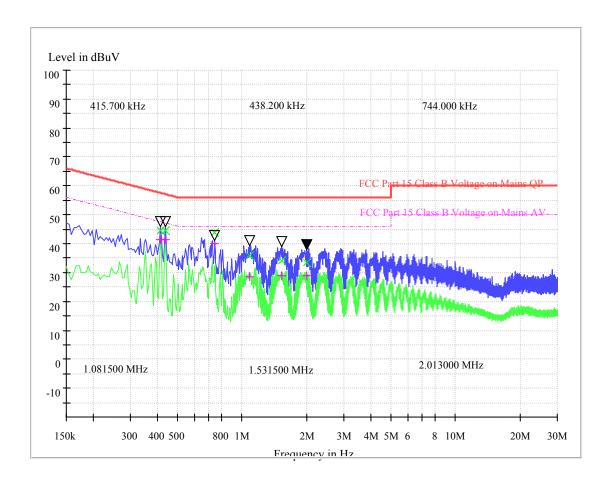
(Plot A: L Phase)

	Conducted Disturbance at Mains Terminals								
	L Test Data								
	QP AV								
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		Frequen cy (MHz)	Limits (dBµV)	Measurem ent Value (dBμV)	Margin (dB)				
0.4165	11.57	45.97	9.65	0.4155	47.50	41.29	6.25		
0.4390	11.10	46.00	15.76	0.4380	47.10	41.31	5.79		
0.7215	17.08	38.92	14.28	0.7215	46.00	32.31	13.69		
0.7890	19.65	36.35	17.19	0.7890	46.00	30.47	15.53		
1.1130	19.72	36.28	15.37	1.1130	46.00	30.53	15.47		
1.4775	19.97	36.03	19.95	1.4775	46.00	28.03	17.97		

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B. Mains terminal disturbance voltage, N phase



(Plot B: N Phase)

	Conducted Disturbance at Mains Terminals								
	N Test Data								
QP AV									
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$			Frequency (MHz)	Limits (dBµV)	Measureme nt Value (dBμV)	Margin (dB)			
0.4157	57.50	44.35	13.19	0.4155	47.50	41.28	6.26		
0.4382	57.10	44.36	12.74	0.4380	47.10	41.31	5.79		
0.7440	56.00	43.67	12.33	0.7440	46.00	40.09	5.91		
1.0815	56.00	35.88	20.12	1.0815	46.00	28.63	17.37		
1.5315	56.00	34.27	21.73	1.5315	46.00	28.86	17.14		
2.0130	56.00	33.30	22.70	2.0130	46.00	29.02	16.98		

Test Result: PASS

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3.2 Radiated Emission

3.2.1 Requirement

According to FCC section 15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency	Field Strength		Field Strength Limitation at 3m Measurement Dist		
range (MHz)	μV/m	Dist	(uV/m)	(dBuV/m)	
0.009 - 0.490	2400/F(kHz)	300m	10000* 2400/F(kHz)	20log 2400/F(kHz) + 80	
0.490 - 1.705	2400/F(kHz)	30m	100* 2400/F(kHz)	20log 2400/F(kHz) + 40	
1.705 - 30.00	30	30m	100*30	20log 30 + 40	
30.0 - 88.0	100	3m	100	20log 100	
88.0 - 216.0	150	3m	150	20log 150	
216.0 - 960.0	200	3m	200	20log 200	
Above 960.0	500	3m	500	20log 500	

- a) As shown in FCC section 15.35(b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.
- b) Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength.
- c) For below 1G: QP detector RBW 120kHz, VBW 300kHz.
- d) For Above 1G: PK detector RBW 1MHz,VBW 3MHz for PK value ;AV detector RBW 1MHz, VBW 10Hz for AV value.

Note:

- 1) The tighter limit shall apply at the boundary between two frequency range.
- 2) Limitation expressed in dBuV/m is calculated by 20log Emission Level(uV/m).
- 3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of Ld1 = Ld2 * $(d2/d1)^2$.

Example:

F.S Limit at 30m distance is 30uV/m, then F.S Limitation at 3m distance is adjusted as Ld1 = L1 = $30uV/m * (10)^2 = 100 * 30uV/m$.

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3.2.2 Test Description

See section 2.3.2 of this report.

3.2.3 Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

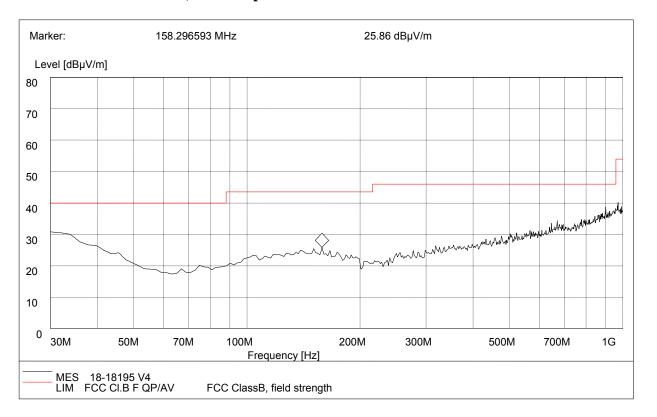
The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

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C. Radiation disturbances, antenna polarization: Vertical



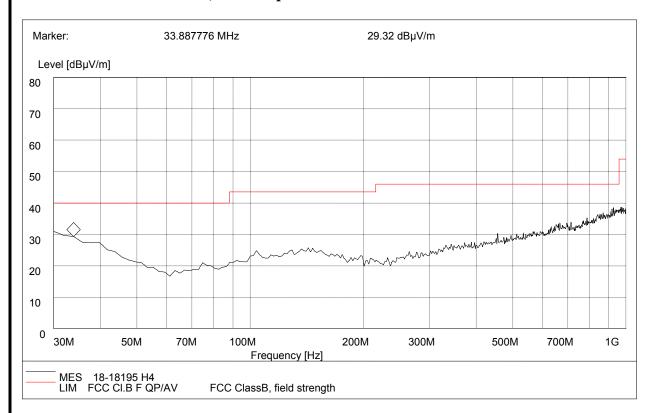
(Plot C: Test Antenna Vertical 30M - 1G)

Frequency (MHz)	QuasiPeak (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dBµV/m)	Margin (dB)	Antenna	Verdict
30.26	29.43	120.000	208.0	40.00	10.57	Vertical	Pass
43.07	23.15	120.000	129.0	40.00	16.85	Vertical	Pass
70.82	20.11	120.000	147.0	40.00	19.89	Vertical	Pass
148.58	22.59	120.000	241.0	43.50	20.91	Vertical	Pass
335.19	24.97	120.000	169.0	46.00	21.03	Vertical	Pass
931.96	37.18	120.000	207.0	46.00	8.82	Vertical	Pass

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D. Radiation disturbances, antenna polarization: Horizontal



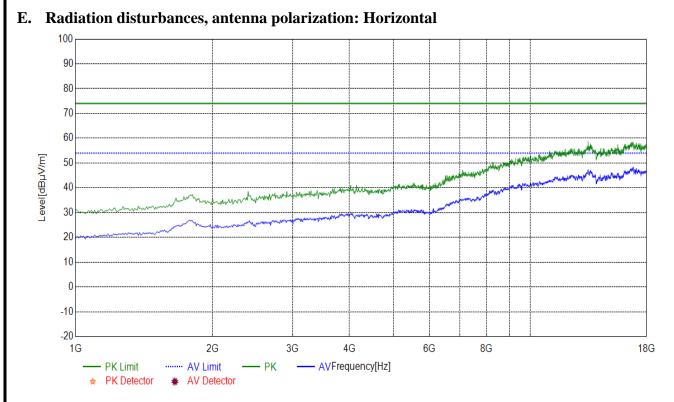
(Plot D: Test Antenna Horizontal 30M - 1G)

Frequency (MHz)	QuasiPeak (dBµV/m)	Bandwidth (kHz)	Antenna height (cm)	Limit (dΒμV/m)	Margin (dB)	Antenna	Verdict
30.00	30.86	120.000	223.0	40.00	9.14	Horizontal	Pass
74.77	20.13	120.000	209.0	40.00	19.87	Horizontal	Pass
100.58	26.75	120.000	126.0	43.50	16.75	Horizontal	Pass
337.13	26.85	120.000	268.0	46.00	19.15	Horizontal	Pass
560.68	31.80	120.000	214.0	46.00	14.20	Horizontal	Pass
657.88	33.91	120.000	364.0	46.00	12.09	Horizontal	Pass

Test Result: PASS

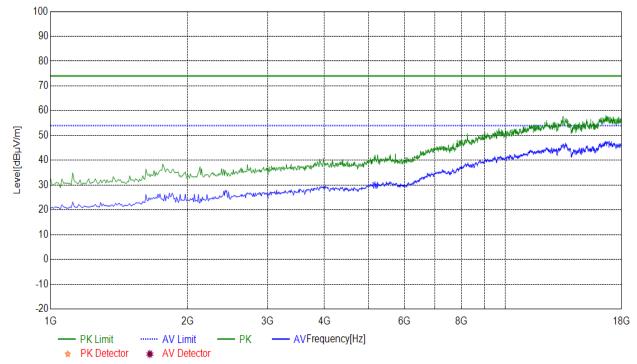
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(Plot E: Test Antenna Horizontal 1G – 18G)

F. Radiation disturbances, antenna polarization: Vertical



(Plot F: Test Antenna Vertical 1G – 18G)

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